

SCCS062B - August 1994 - Revised September 2001

# 18-Bit Registers

#### **Features**

- Ioff supports partial-power-down mode operation
- Edge-rate control circuitry for significantly improved noise characteristics
- Typical output skew < 250 ps</li>
- ESD > 2000V
- TSSOP (19.6-mil pitch) and SSOP (25-mil pitch) packages
- Industrial temperature range of -40°C to +85°C
- $V_{CC} = 5V \pm 10\%$

#### CY74FCT16823T Features:

- · 64 mA sink current, 32 mA source current
- Typical  $V_{OLP}$  (ground bounce) <1.0V at  $V_{CC}$  = 5V,  $T_A$  = 25°C

#### CY74FCT162823T Features:

- · Balanced 24 mA output drivers
- · Reduced system switching noise
- Typical V<sub>OLP</sub> (ground bounce) <0.6V at V<sub>CC</sub> = 5V, TA = 25°C

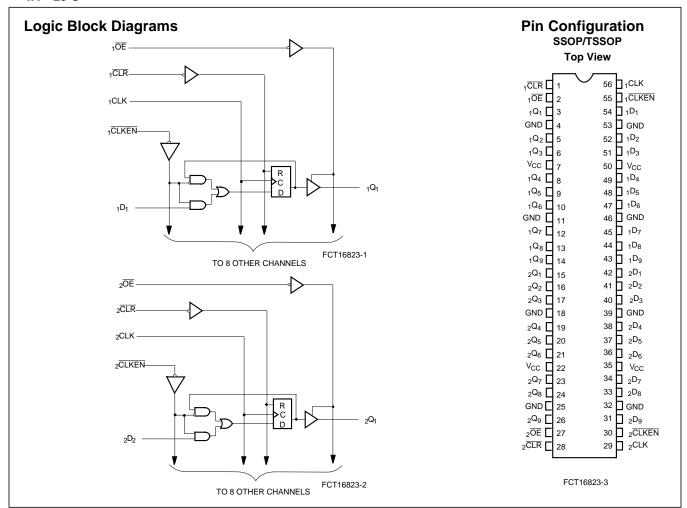
#### **Functional Description**

The CY74FCT16823T and the CY74FCT162823T 18-bit bus interface registers are designed for use in high-speed, low-power systems needing wide registers and parity. 18-bit operation is achieved by connecting the control lines of the two 9-bit registers. Flow-through pinout and small shrink packaging aids in simplifying board layout.

This device is fully specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

The CY74FCT16823T is ideally suited for driving high-capacitance loads and low-impedance backplanes.

The CY74FCT162823T has 24-mA balanced output drivers with current limiting resistors in the outputs. This reduces the need for external terminating resistors and provides for minimal undershoot and reduced ground bounce. The CY74FCT162823T is ideal for driving transmission lines.





#### **Pin Description**

Name	Description
D	Data Inputs
CLK	Clock Inputs
CLKEN	Clock Enable Inputs (Active LOW)
CLR	Asynchronous Clear Inputs (Active LOW)
ŌĒ	Output Enable Inputs (Active LOW)
Q	Three-State Outputs

#### Function Table<sup>[1]</sup>

	Inputs					
ŌĒ	CLR	CLKEN	CLK	D	Q	Function
Н	Х	Х	Х	Χ	Z	High Z
L	L	Х	Х	Х	L	Clear
L	Н	Н	Х	Х	Q <sup>[2]</sup>	Hold
Н	Н	L	Т	L	Z	Load
Н	Н	L	Т	Н	Z	
L	Н	L	Т	L	L	
L	Н	L	Т	Н	Н	

## Maximum Ratings<sup>[3, 4]</sup>

(Above which the useful life may guidelines, not tested.)	be impaired. For user
Storage Temperature	55°C to +125°C
Ambient Temperature with Power Applied	55°C to +125°C
DC Input Voltage	0.5V to +7.0V
DC Output Voltage	0.5V to +7.0V
DC Output Current (Maximum Sink Current/Pin)	60 to +120 mA

Power Dissipation	1.0W
Static Discharge Voltage	>2001V
(per MIL-STD-883, Method 3015)	

## **Operating Range**

Range	Ambient Temperature	V <sub>CC</sub>
Industrial	–40°C to +85°C	5V ± 10%

#### Notes:

- H = HIGH Voltage Level.
   L = LOW Voltage Level.
   X = Don't Care.
   Z = HIGH Impedance.
- T=LOW-to-HIGH transition.

  Output level before indicated steady-state input conditions were established.

  Operation beyond the limits set forth may impair the useful life of the device. Unless otherwise noted, these limits are over the operating free-air temperature range.

  Unused inputs must always be connected to an appropriate logic voltage level, preferably either V<sub>CC</sub> or ground.



#### **Electrical Characteristics** Over the Operating Range

Parameter	Description	Test Conditions	Min.	<b>Typ.</b> <sup>[5]</sup>	Max.	Unit
V <sub>IH</sub>	Input HIGH Voltage		2.0			V
V <sub>IL</sub>	Input LOW Voltage				0.8	V
V <sub>H</sub>	Input Hysteresis <sup>[6]</sup>			100		mV
V <sub>IK</sub>	Input Clamp Diode Voltage	V <sub>CC</sub> =Min., I <sub>IN</sub> =-18 mA		-0.7	-1.2	V
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> =Max., V <sub>I</sub> =V <sub>CC</sub>			±1	μΑ
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> =Max., V <sub>I</sub> =GND			±1	μΑ
I <sub>OZH</sub>	High Impedance Output Current (Three-State Output pins)	V <sub>CC</sub> =Max., V <sub>OUT</sub> =2.7V			±1	μА
I <sub>OZL</sub>	High Impedance Output Current (Three-State Output pins)	V <sub>CC</sub> =Max., V <sub>OUT</sub> =0.5V			±1	μΑ
Ios	Short Circuit Current <sup>[7]</sup>	V <sub>CC</sub> =Max., V <sub>OUT</sub> =GND	-80	-140	-200	mA
I <sub>O</sub>	Output Drive Current <sup>[7]</sup>	V <sub>CC</sub> =Max., V <sub>OUT</sub> =2.5V	-50		-180	mA
I <sub>OFF</sub>	Power-Off Disable	V <sub>CC</sub> =0V, V <sub>OUT</sub> ≤4.5V <sup>[8]</sup>			1	μΑ

## **Output Drive Characteristics for CY74FCT16823T**

Parameter	Description	Test Conditions	Min.	<b>Typ.</b> <sup>[5]</sup>	Max.	Unit
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> =Min., I <sub>OH</sub> =-3 mA	2.5	3.5		V
		V <sub>CC</sub> =Min., I <sub>OH</sub> =-15 mA	2.4	3.5		
		V <sub>CC</sub> =Min., I <sub>OH</sub> =-32 mA	2.0	3.0		
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> =Min., I <sub>OL</sub> =64 mA		0.2	0.55	V

#### **Output Drive Characteristics for CY74FCT162823T**

Parameter	Description	Test Conditions	Min.	<b>Typ.</b> <sup>[5]</sup>	Max.	Unit
I <sub>ODL</sub>	Output LOW Voltage <sup>[7]</sup>	V <sub>CC</sub> =5V, V <sub>IN</sub> =V <sub>IH</sub> or V <sub>IL</sub> , V <sub>OUT</sub> =1.5V	60	115	150	mA
I <sub>ODH</sub>	Output HIGH Voltage <sup>[7]</sup>	$V_{CC}$ =5V, $V_{IN}$ = $V_{IH}$ or $V_{IL}$ , $V_{OUT}$ =1.5V	-60	-115	-150	mA
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> =Min., I <sub>OH</sub> =-24 mA	2.4	3.3		V
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> =Min., I <sub>OL</sub> =24 mA		0.3	0.55	V

## **Capacitance**[9] $(T_A = +25^{\circ}C, f = 1.0 \text{ MHz})$

Parameter	Description	Test Conditions	<b>Typ.</b> <sup>[5]</sup>	Max.	Unit
C <sub>IN</sub>	Input Capacitance	$V_{IN} = 0V$	4.5	6.0	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V	5.5	8.0	pF

- Typical values are at V<sub>CC</sub>= 5.0V, T<sub>A</sub>= +25°C ambient.
   This input is specified but not tested.
   Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parametric tests. In any sequence of parameter tests, I<sub>O</sub> set sets should be performed last.
- 8. Tested at +25°C.
  9. This parameter is specified but not tested.



## **Power Supply Characteristics**

Parameter	Description	Test Condit	ions <sup>[10]</sup>	Min.	Typ. <sup>[5]</sup>	Max.	Unit
I <sub>CC</sub>	Quiescent Power Supply Current	V <sub>CC</sub> =Max.	V <sub>IN</sub> ≤0.2V V <sub>IN</sub> ≥V <sub>CC</sub> -0.2V	_	5	500	μΑ
Δl <sub>CC</sub>	Quiescent Power Supply Current (TTL inputs HIGH)	V <sub>CC</sub> =Max.	V <sub>IN</sub> =3.4V <sup>[11]</sup>	_	0.5	1.5	mA
I <sub>CCD</sub>	Dynamic Power Supply Current <sup>[12]</sup>	V <sub>CC</sub> =Max., One Input Toggling, 50% Duty Cycle, Outputs Open, OE=CLKEN=GND	V <sub>IN</sub> =V <sub>CC</sub> or V <sub>IN</sub> =GND	_	75	120	μΑ/ MHz
I <sub>C</sub>		f <sub>0</sub> =10 MHz, 50% Duty Cycle, Outputs Open, One Bit Toggling, OE=CLKEN=GND at f <sub>1</sub> =5 MHz V <sub>CC</sub> =Max., at f <sub>1</sub> =2.5 MHz,	V <sub>IN</sub> =V <sub>CC</sub> or V <sub>IN</sub> =GND	_	0.8	1.7	mA
			V <sub>IN</sub> =3.4V or V <sub>IN</sub> =GND	_	1.3	3.2	
			V <sub>IN</sub> =V <sub>CC</sub> or V <sub>IN</sub> =GND	_	4.2	7.1 <sup>[14]</sup>	
	50% Duty Cycle, Outputs Open, Eighteen Bits Toggling, OE=CLKEN=GND f <sub>0</sub> =10 MHz	V <sub>IN</sub> =3.4V or V <sub>IN</sub> =GND	_	9.2	22.1 <sup>[14]</sup>		

Notes:
10. For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
11. Per TTL driven input (V<sub>IN</sub>=3.4V); all other inputs at V<sub>CC</sub> or GND.
12. This parameter is not directly testable, but is derived for use in Total Power Supply calculations.
13. I<sub>C</sub> = I<sub>QUIESCENT</sub> + I<sub>INPUTS</sub> + I<sub>DYNAMIC</sub> I<sub>C</sub> = I<sub>CC</sub>+ΔI<sub>CC</sub>D<sub>H</sub>N<sub>T</sub>+I<sub>CCD</sub>(f<sub>0</sub>/2 + f<sub>1</sub>N<sub>1</sub>) I<sub>CC</sub> = Quiescent Current with CMOS input levels

 $\begin{array}{lll} I_C &=& I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD} U_{0/2} + \dots \\ I_{CC} &=& Quiescent Current with CMOS input levels \\ \Delta I_{CC} &=& Power Supply Current for a TTL HIGH input (<math>V_{IN}$ =3.4V) \\ D\_H &=& Duty Cycle for TTL inputs HIGH \\ &=& Consistion pair (HLf) \\ \end{array}

BH = Duty Cycle for TTL injuts FIGH

N<sub>T</sub> = Number of TTL injuts at D<sub>H</sub>

I<sub>CCD</sub> = Dynamic Current caused by an input transition pair (HLH or LHL)

f<sub>0</sub> = Clock frequency for registered devices, otherwise zero

f<sub>1</sub> = Injut signal frequency

T<sub>1</sub> = Input signal frequency
 N<sub>1</sub> = Number of inputs changing at f<sub>1</sub>
 All currents are in milliamps and all frequencies are in megahertz.
 Values for these conditions are examples of the I<sub>CC</sub> formula. These limits are specified but not tested.



## **Switching Characteristics** Over the Operating Range<sup>[15]</sup>

				CY74FCT16823AT CY74FCT162823AT		
Parameter	Description	Condition <sup>[16]</sup>	Min.	Max.	Unit	Fig.No. <sup>[16]</sup>
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay CLK to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	10.0	ns	1, 5
		$C_L = 300 \text{ pF}^{[17]}$ $R_L = 500\Omega$	1.5	20.0		
t <sub>PHL</sub>	Propagation Delay CLR to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	14.0	ns	1, 5
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time OE to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	12.0	ns	1, 7, 8
		$C_L = 300 \text{ pF}^{[17]}$ $R_L = 500\Omega$	1.5	23.0		
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output Disable Time OE to Q	$C_L=5 \text{ pF}^{[17]}$ $R_L=500\Omega$	1.5	7.0	ns	1, 7, 8
		$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	8.0		
t <sub>SU</sub>	Set-Up Time HIGH or LOW, D to CLK	C <sub>L</sub> =50 pF	3.0	_	ns	4
t <sub>H</sub>	Hold Time HIGH or LOW, D to CLK	$R_L^-=500\Omega$	1.5	_	ns	4
t <sub>SU</sub>	Set-Up Time HIGH or LOW, CLKEN to CLK		3.0	_	ns	9
t <sub>H</sub>	Hold Time HIGH or LOW CLKEN to CLK		0.0	_	ns	9
t <sub>W</sub>	CLK Pulse Width HIGH or LOW		6.0	_	ns	5
t <sub>W</sub>	CLR Pulse Width LOW		6.0	_	ns	5
t <sub>REM</sub>	Recovery Time CLR to CLK		6.0	_	ns	6
t <sub>SK(O)</sub>	Output Skew <sup>[18]</sup>		_	0.5	ns	_

## Switching Characteristics Over the Operating Range<sup>[15]</sup>

			CY74FCT16823CT CY74FCT162823CT			
Parameter	Description	Condition <sup>[16]</sup>	Min.	Max.	Unit	Fig.No. <sup>[16]</sup>
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay CLK to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	6.0	ns	1, 5
		$C_L = 300 \text{ pF}^{[17]}$ $R_L = 500\Omega$	1.5	12.5		
t <sub>PHL</sub>	Propagation Delay CLR to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	6.1	ns	1, 5
t <sub>PZH</sub>	Output Enable Time  OE to Q	$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	5.5	ns	1, 7, 8
		$C_L = 300 \text{ pF}^{[17]}$ $R_L = 500\Omega$	1.5	12.5		
t <sub>PHZ</sub>	Output Disable Time OE to Q	$C_L=5 \text{ pF}^{[17]} \ R_L=500\Omega$	1.5	5.2	ns	1, 7, 8
		$C_L$ =50 pF $R_L$ =500 $\Omega$	1.5	6.5		



## **Switching Characteristics** Over the Operating Range<sup>[15]</sup> (continued)

			CY74FCT16823CT CY74FCT162823CT			
Parameter	Description	Condition <sup>[16]</sup>	Min.	Max.	Unit	Fig.No. <sup>[16]</sup>
t <sub>SU</sub>	Set-Up Time HIGH or LOW, D to CLK	$C_L$ =50 pF $R_L$ =500 $\Omega$	2.0	_	ns	4
t <sub>H</sub>	Hold Time HIGH or LOW, D to CLK		1.5	_	ns	4
t <sub>SU</sub>	Set-Up Time HIGH or LOW, CLKEN to CLK		3.0	_	ns	9
t <sub>H</sub>	Hold Time HIGH or LOW CLKEN to CLK		0.0	_	ns	9
t <sub>W</sub>	CLK Pulse Width HIGH or LOW		3.3	_	ns	5
t <sub>W</sub>	CLR Pulse Width LOW		3.3	_	ns	5
t <sub>REM</sub>	Recovery Time CLR to CLK		6.0	_	ns	6
t <sub>SK(O)</sub>	Output Skew <sup>[18]</sup>		_	0.5	ns	_

#### Notes:

- Minimum limits are specified but not tested on Propagation Delays.
   See "Parameter Measurement Information" in the General Information section.
   These limits are specified but not tested.
   Skew between any two outputs of the same package switching in the same direction. This parameter is ensured by design.

## **Ordering Information CY74FCT16823**

Speed (ns)	Ordering Code	Ordering Code Package Name		Operating Range
6.0	CY74FCT16823CTPACT	Z56	56-Lead (240-Mil) TSSOP	Industrial
	CY74FCT16823CTPVC/PVCT	O56	56-Lead (300-Mil) SSOP	
10.0	CY74FCT16823ATPACT	Z56	56-Lead (240-Mil) TSSOP	Industrial

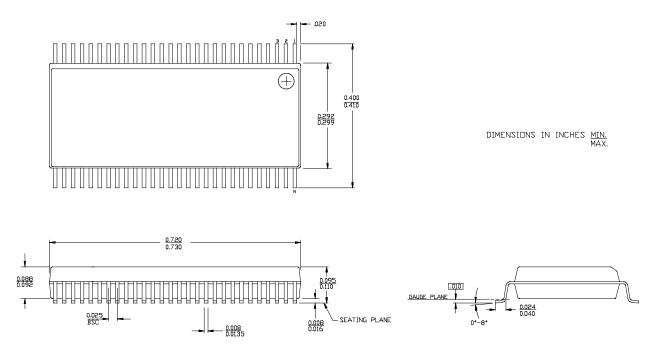
## **Ordering Information CY74FCT162823**

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
6.0	74FCT162823CTPACT	Z56	56-Lead (240-Mil) TSSOP	Industrial
	CY74FCT162823CTPVC	O56	56-Lead (300-Mil) SSOP	
	74FCT162823CTPVCT	O56	56-Lead (300-Mil) SSOP	
10.0	74FCT162823ATPACT	Z56	56-Lead (240-Mil) TSSOP	Industrial

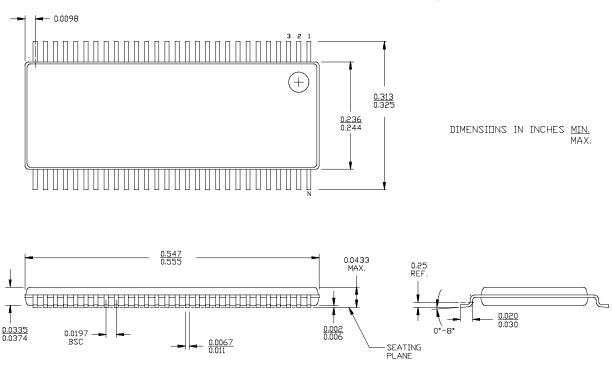


## **Package Diagrams**

#### 56-Lead Shrunk Small Outline Package O56



## 56-Lead Thin Shrunk Small Outline Package Z56







17-May-2014

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
74FCT162823CTPVCG4	ACTIVE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85		Samples
74FCT162823ETPACT	OBSOLETE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		
74FCT162823ETPVCT	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85		
74FCT16823ATPACTE4	ACTIVE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		Samples
74FCT16823ATPACTG4	ACTIVE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		Samples
74FCT16823CTPACTE4	ACTIVE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		Samples
74FCT16823CTPACTG4	ACTIVE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		Samples
74FCT16823CTPVCG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823C	Samples
74FCT16823CTPVCTG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823C	Samples
CY74FCT162823CTPVC	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT162823C	Samples
CY74FCT162823ETPAC	OBSOLETE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		
CY74FCT162823ETPVC	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85		
CY74FCT16823ATPACT	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823A	Samples
CY74FCT16823CTPACT	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823C	Samples
CY74FCT16823CTPVC	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823C	Samples
CY74FCT16823CTPVCT	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT16823C	Samples
CY74FCT16823ETPAC	OBSOLETE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		
CY74FCT16823ETPACT	OBSOLETE	TSSOP	DGG	56		TBD	Call TI	Call TI	-40 to 85		
CY74FCT16823ETPVC	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85		
CY74FCT16823ETPVCT	OBSOLETE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85		

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.



## PACKAGE OPTION ADDENDUM

17-May-2014

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component has a Rohs exemption for eitner 1) lead-based filip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RohS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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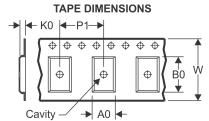
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## PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





Α0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter	Reel Width	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	Туре	Diawing				W1 (mm)	(11111)	(11111)	(11111)	(11111)	(11111)	Quadrant
CY74FCT16823ATPACT	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
CY74FCT16823CTPACT	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
CY74FCT16823CTPVCT	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1

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#### \*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT16823ATPACT	TSSOP	DGG	56	2000	367.0	367.0	45.0
CY74FCT16823CTPACT	TSSOP	DGG	56	2000	367.0	367.0	45.0
CY74FCT16823CTPVCT	SSOP	DL	56	1000	367.0	367.0	55.0

## DL (R-PDSO-G56)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

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#### DGG (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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